

<b>Notice of References Cited</b>	Application/Control No. 09/827,332	Applicant(s)/Patent Under Reexamination KELBAUGH ET AL.	
	Examiner Satish S. Rampuria	Art Unit 2124	Page 1 of 2

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	Examiner Satish S. Rampuria	Art Unit 2124	Page 2 of 2

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